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Anna Vilanova Bartrolí , Rainer Wegenkittl , Andreas König , Eduard Gröller
Proceedings of the conference on Visualization '01 October 2001

> The majority of virtual endoscopy techniques tries to simulate a real endoscopy. A real endoscopy does not always give the optimal information due to the physical limitations it is subject to. In this paper, we deal with the unfolding of the surface of the colon as a possible visualization technique for diagnosis and polyp detection. A new two-step technique is presented which deals with the problems of double appearance of polyps and nonuniform sampling that other colon unfolding techniques suf ...

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and tracking in real-time news broadcasting analysis
Lie Lu , Hong-Jiang Zhang
Proceedings of the tenth ACM international conference on Multimedia December 2002

> This paper addresses the problem of real time speaker change detection and speaker tracking in broadcasted news video analysis. In such a case, both speaker identities and number of speakers are assumed unknown. A two-step speaker change detection algorithm, including potential change detection and refinement, is proposed. Speaker tracking is performed based on the results of speaker change detection. A Bayesian Fusion method is used to fuse multiple audio features to get a more reliable result. ...

3 Virtual voyage: interactive navigation in the human colon   77%
Lichan Hong , Shigeru Muraki , Arie Kaufman , Dirk Bartz , Taosong He
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Mark Foskey , Ming C. Lin , Dinesh Manocha
Proceedings of the eighth ACM symposium on Solid modeling and applications
June 2003
> Applications of of the medial axis have been limited because of its instability and algebraic complexity. In this paper, we use a simplification of the medial axis, the θ-SMA, that is parameterized by a separation angle (θ) formed by the vectors connecting a point on the medial axis to the closest points on the boundary. We present a formal characterization of the degree of simplification of the θ-SMA as a function of θ, and we quantify the degree ...

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> (distance <near/2> (map* <or> transform*
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Interpretation of 3D Scenes, 1989. Proceedings.,
Workshop on , 27-29 Nov. 1989
Page(s): 162 -169

[Abstract] [PDF Full-Text (652 KB)] **IEEE CNF**

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2 **A pseudo-distance map for the segmentation-free
skeletonization of gray-scale images**
Jeong-Hun Jang; Ki-Sang Hong;
Computer Vision, 2001. ICCV 2001. Proceedings. Eighth
IEEE International Conference on , Volume: 2 , 7-14 July
2001
Page(s): 18 -23 vol.2

[Abstract] [PDF Full-Text (628 KB)] **IEEE CNF**

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3 **EODM-a novel representation for collision
detection**
*Amezquita Benitez, M.D.C.; Gupta, K.K.; Bhattacharya,
B.;*
Robotics and Automation, 2000. Proceedings. ICRA '00.
IEEE International Conference on , Volume: 4 , 24-28
April 2000
Page(s): 3727 -3732 vol.4

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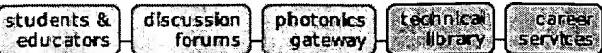© 1994–2002 SPIE—The International Society for Optical Engineering
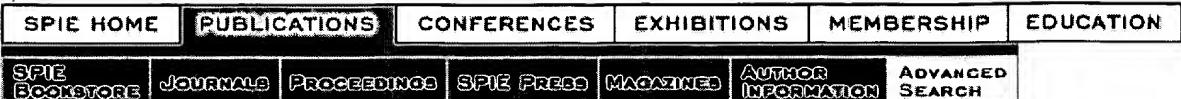
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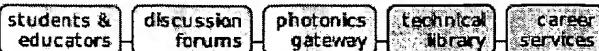© 1994–2002 SPIE—The International Society for Optical Engineering
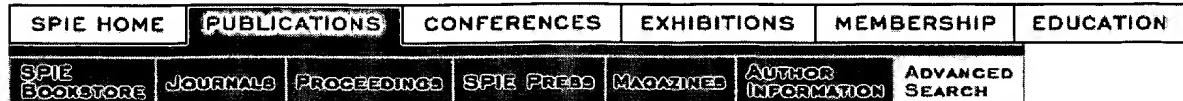
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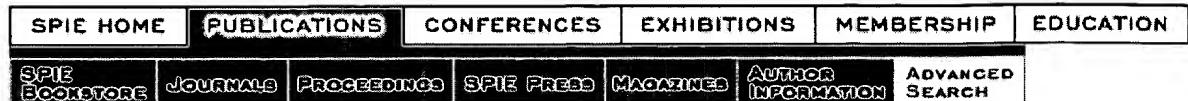
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No results were found for:
- **distance AND map AND (subpixel OR (sub pixel) OR subgrid) OR (sub grid))**

Try using related or less specific search terms.